

## **DESCRIPTION**

The AM2306 is the N-Channel logic enhancement mode power field effect transistor is produced using high cell density. Advanced trench technology to provide excellent R<sub>DS(ON)</sub>.

This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application, and low in-line power loss are needed in a very small outline surface mount package.

AM2306 is available in a SOT-23 package.

### ORDERING INFORMATION

| Package Type                      | Part Number      |            |  |  |
|-----------------------------------|------------------|------------|--|--|
| SOT-23                            | Го               | AM2306E3R  |  |  |
|                                   | E3               | AM2306E3VR |  |  |
| Note                              | R: Tape & Reel   |            |  |  |
| Note                              | V: Green Package |            |  |  |
| AiT provides all Pb free products |                  |            |  |  |
| Suffix " V " means Green Package  |                  |            |  |  |

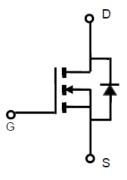
## **FEATURES**

- -30V/3.6A,  $R_{DS(ON)}$ = 45m $\Omega$ (typ.)@V<sub>GS</sub>= 10V
- 30V/2.8A,  $R_{DS(ON)} = 55m\Omega(typ.)@V_{GS} = 4.5V$
- Super high density cell design for extremely low R<sub>DS(ON)</sub>
- Exceptional on-resistance and Maximum DC current capability
- Available in a SOT-23 package.

### **APPLICATION**

- Power Management in Note book
- Portable Equipment
- DSC
- LCD Display inverter
- Battery Powered System
- DC/DC Converter

## P CHANNEL MOSFET

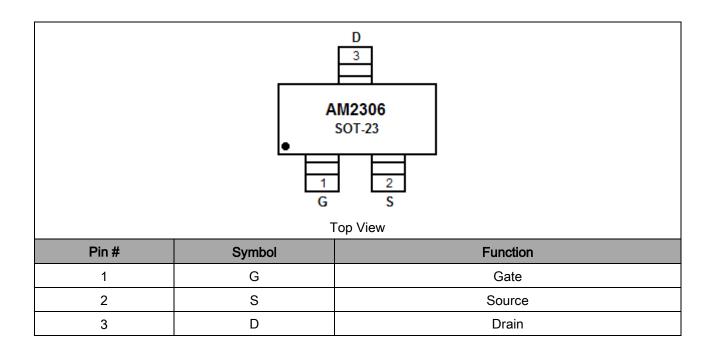


N-Channel

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# PIN DESCRIPTION



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# ABSOLUTE MAXIMUM RATINGS

T<sub>A</sub> = 25°C Unless otherwise noted

| V <sub>DSS</sub> , Drain-Source Voltage                       |                      |
|---|----------------------|
| V <sub>GSS</sub> , Gate-Source Voltage                        |                      |
| V <sub>GS</sub> =10V  | 4.0A                 |
| I <sub>DM</sub> , Pulsed Drain Current                        |                      |
| I <sub>S</sub> , Continuous Source Current (Diode Conduction) |                      |
| P <sub>D</sub> , Power Dissipation                            |                      |
| T <sub>A</sub> =25°C  |                      |
| T <sub>A</sub> =70°C  |                      |
| T <sub>J</sub> , Operation Junction Temperature               |                      |
| T <sub>STG</sub> , Storage Temperature Range                  |                      |
|   | V <sub>GS</sub> =10V |

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# THERMAL DATA

| Parameter                              | Symbol          | Max | Unit |
|--|-----------------|-----|------|
| Thermal Resistance-Junction to Ambient | $R_{\theta JA}$ | 120 | °C/W |

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# **ELECTRICAL CHARACTERISTICS**

T<sub>A</sub> = 25°C Unless otherwise specified

| Symbol   | Parameter                                 | Conditions   | Min | Тур. | Max  | Units |
|--|---|--|-----|------|------|-------|
| Static Param                                   | eters                                     |  |     |      |      |       |
| V <sub>(BR)DSS</sub>                           | Drain-Source Breakdown<br>Voltage         | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA                       | 30  | -    | -    | V     |
| $V_{GS(th)}$                                   | Gate Threshold Voltage                    | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA         | 1.0 | -    | 2.5  | V     |
| I <sub>GSS</sub>                               | Gate Leakage Current                      | V <sub>DS</sub> =0V,V <sub>GS</sub> =±20V                        | -   | -    | ±100 | nA    |
|  | Zero Gate Voltage Drain                   | V <sub>DS</sub> =30V,V <sub>GS</sub> =0V                         | -   | -    | 1    |       |
| I <sub>DSS</sub>                               |   | V <sub>DS</sub> =30V,V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C | -   | -    | 10   | μA    |
| I <sub>D(ON)</sub>                             | On-State Drain Current                    | V <sub>DS</sub> ≧5V,V <sub>GS</sub> =10V                         | 6   | -    | -    | Α     |
| R <sub>DS(ON)</sub> Drain-source On-Resistance | V <sub>GS</sub> =10V,I <sub>D</sub> =3.6A | -  | 45  | 55   |      |       |
|  | Drain-source On-Resistance                | V <sub>GS</sub> =4.5V,I <sub>D</sub> =2.8A                       | -   | 55   | 60   | mΩ    |
| Gfs  | Forward Transconductance                  | V <sub>DS</sub> =15V,I <sub>D</sub> =5.0A                        | -   | 4.5  | -    | S     |
| Source-Drain                                   | Diode                                     |  |     |      |      |       |
| V <sub>SD</sub>                                | Diode Forward Voltage                     | I <sub>S</sub> =1.25A,V <sub>GS</sub> =0V                        | -   | 0.8  | 1.2  | V     |
| Dynamic Par                                    | ameters                                   |  |     |      |      |       |
| Qg   | Total Gate Charge                         | V <sub>DS</sub> =15V   | -   | 4.5  | 10   |       |
| Q <sub>gs</sub>                                | Gate-Source Charge                        | V <sub>GS</sub> =10V   | -   | 0.8  | -    | nC    |
| $Q_{\text{gd}}$                                | Gate-Drain Charge                         | I <sub>D</sub> ≡2.5A   | -   | 1.0  | -    |       |
| Ciss   | Input Capacitance                         | V <sub>DS</sub> =15V   | -   | 380  | -    |       |
| Coss   | Output Capacitance                        |  | -   | 70   | -    |       |
| Crss   | Reverse Transfer Capacitance              | V <sub>GS</sub> =0V<br>f=1MHz                                    | -   | 40   | -    | pF    |
| t <sub>d(ON)</sub>                             | T O . Ti .                                | V <sub>DD</sub> =15V   | -   | 8    | 20   |       |
| Tr   | Turn-On Time                              | R <sub>L</sub> =15Ω  | -   | 6    | 16   |       |
| $t_{\text{d(OFF)}}$                            |   | I <sub>D</sub> =1.0A   | -   | 20   | 35   | nS    |
| Tf   | Turn-Off Time                             | $V_{GEN}$ =10V $R_{G}$ =6 $\Omega$                               | -   | 5    | 15   |       |

NOTE: 1. Pulse test: pulse width <= 300us, duty cycle<= 2%

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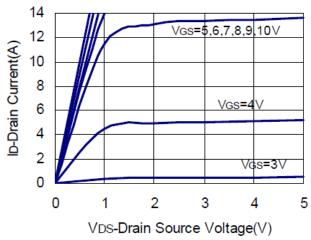
<sup>2.</sup> Static parameters are based on package level with recommended wire-bonding



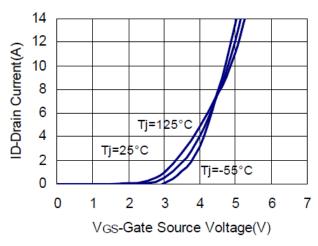
### TYPICAL CHARACTERISTICS

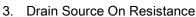
25°C Unless Specified

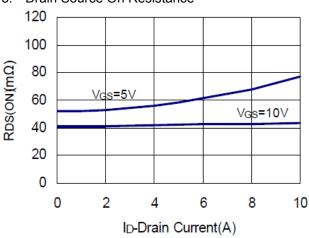
1. Output Characteristics



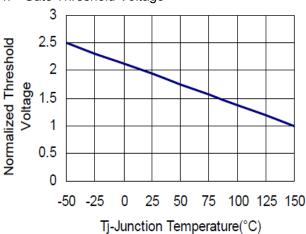
2. Transfer Characteristics



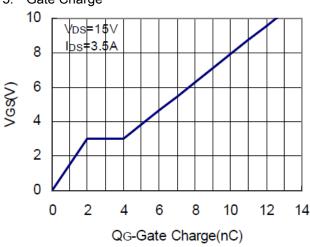




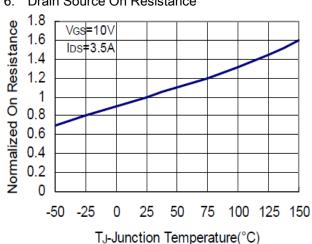
4. Gate Threshold Voltage



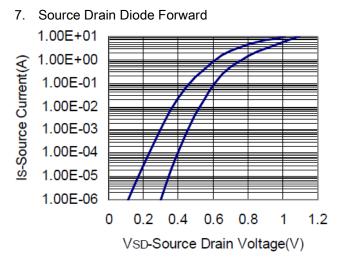
5. Gate Charge

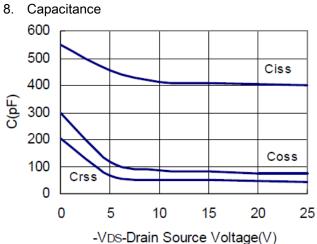


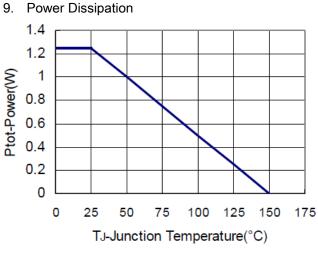
6. Drain Source On Resistance

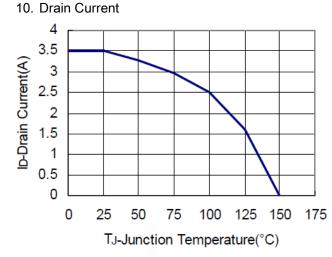


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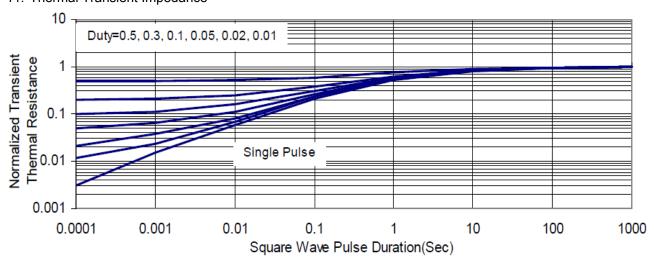








### 11. Thermal Transient Impedance

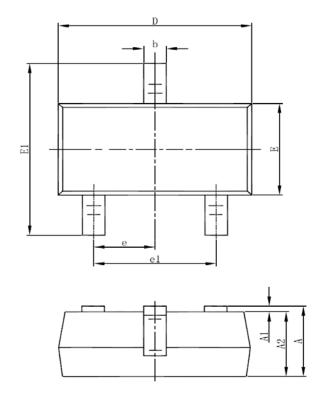


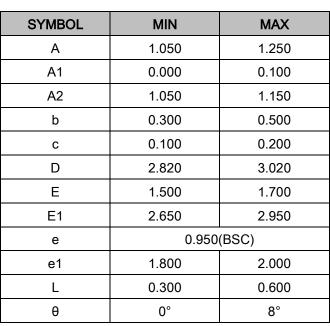
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# **PACKAGE INFORMATION**

Dimension in SOT-23 Package (Unit: mm)







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